

Joint ICTP-IAEA Advanced Workshop on High Sensitivity 2D & 3D
Characterisation and Imaging with Ion Beams | (smr 2856)

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The SYRMEP X-ray imaging beamline at Elettra: recent achievements and future perspectives

Wednesday, 28 September 2016 16:00 (0:30)

Content

Summary

Presenter(s) : TROMBA, Giuliana (Elettra Sincrotrone Trieste)

Session Classification : DAY 3